

**Notice of References Cited**

Application/Control No.

10/578,777

Applicant(s)/Patent Under  
Reexamination  
KAYA ET AL.

Examiner

MARC A. PATTERSON

Art Unit

1782

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-4,138,026	02-1979	Conklin, Charles S.	215/12.2
*	C	US-2003/0152792	08-2003	Takayasu et al.	428/515
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	N	JP-01037323	02-1989	Japan	Murakami et al.	
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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